		19	Filling or coating of groove or
This Class 216 is considered to be an		10	through hole in a conductor
integral part of Class 156 (see the Class			with an insulator
156 schedule for the position of this		20	.Adhesive or autogenous bonding
Class in schedule hierarchy). This Class		20	of self-sustaining preforms
retains all pertinent definitions and			(e.g., prefabricated base,
	ines of Class 156.		etc.)
		21	.Repairing circuit
		22	FORMING OR TREATING ARTICLE
			CONTAINING MAGNETICALLY
2	ETCHING OF SEMICONDUCTOR MATERIAL		RESPONSIVE MATERIAL
_	TO PRODUCE AN ARTICLE HAVING A	23	FORMING OR TREATING ARTICLE
	NONELECTRICAL FUNCTION		CONTAINING A LIQUID CRYSTAL
3	FORMING OR TREATING JOSEPHSON		MATERIAL
	JUNCTION ARTICLE	24	FORMING OR TREATING OPTICAL
4	FORMING OR TREATING A SIGN OR		ARTICLE
	MATERIAL USEFUL IN A SIGN	25	.Phosphor screen
5	.Sign or material is	26	.Lens
	electroluminescent	27	FORMING OR TREATING THERMAL INK
6	FORMING OR TREATING MATERIAL		JET ARTICLE (E.G., PRINT HEAD,
	USEFUL IN A CAPACITOR		LIQUID JET RECORDING HEAD,
7	FORMING OR TREATING FIBROUS		ETC.)
	ARTICLE OR FIBER REINFORCED	28	FORMING OR TREATING AN ORNAMENTED
	COMPOSITE STRUCTURE		ARTICLE
8	FORMING OR TREATING CYLINDRICAL	29	.Wood surface treated or wood
	OR TUBULAR ARTICLE HAVING		grain produced
	PATTERN OR DESIGN ON ITS	30	.Treating stone (e.g., marble,
	SURFACE		etc.)
9	.Forming or treating an embossing	31	.Treating glass (e.g., mirror,
	cylinder or tubular article		etc.)
10	.Forming or treating liquid	32	.Treating elemental metal or
	transfer cylinder or tubular	2.2	alloy thereof
	article (e.g., printing roll,	33	ADHESIVE OR AUTOGENOUS BONDING OF
	etc.)		TWO OR MORE SELF-SUSTAINING
11	FORMING OR TREATING AN ARTICLE		PREFORMS WHEREIN AT LEAST TWO
	WHOSE FINAL CONFIGURATION HAS		OF THE PREFORMS ARE NOT
1.0	A PROJECTION		INTENDED TO BE REMOVED (E.G., PREFABRICATED BASE, ETC.)
12	FORMING OR TREATING MASK USED FOR	34	Etching improves or promotes
	ITS NONETCHING FUNCTION (E.G.,	34	adherence of preforms being
1 2	SHADOW MASK, X-RAY MASK, ETC.) FORMING OR TREATING ELECTRICAL		bonded
13	CONDUCTOR ARTICLE (E.G.,	35	Bonding of preform of metal or
	CIRCUIT, ETC.)		an alloy thereof to a preform
14	.Forming or treating lead frame		of a nonmetal
T. 4	or beam lead	36	.Removing at least one of the
15	.Forming or treating a crossover		self-sustaining preforms or a
16	.Forming or treating a crossover		portion thereof
10	material	37	ETCHING AND COATING OCCUR IN THE
17	.Forming or treating of groove or		SAME PROCESSING CHAMBER
± /	through hole	38	PLANARIZING A NONPLANAR SURFACE
18	Filling or coating of groove or	39	FORMING GROOVE OR HOLE IN A
10	through hole with a conductor		SUBSTRATE WHICH IS
	to form an electrical		SUBSEQUENTLY FILLED OR COATED
	interconnection		

40	FORMING PATTERN USING LIFT OFF	65	Using laser
	TECHNIQUE	66	Using ion beam, ultraviolet, or
41	MASKING OF A SUBSTRATE USING		visible light
	MATERIAL RESISTANT TO AN	67	Using plasma
	ETCHANT (I.E., ETCH RESIST)	68	Using coil to generate the
42	.Resist material applied in		plasma
	particulate form or spray	69	Using microwave to generate
43	.Adhesively bonding resist to		the plasma
	substrate	70	Magnetically enhancing the
44	.Mechanically forming pattern		plasma
	into a resist	71	Specific configuration of
45	.Mask is reusable (i.e., stencil)		electrodes to generate the
46	.Masking of sidewall		plasma
47	.Mask is multilayer resist	72	.Etching a multiple layered
48	.Mask is exposed to nonimaging		substrate where the etching
	radiation		condition used produces a
49	.Mask resist contains organic		different etching rate or
	compound		characteristic between at
50	Mask resist contains a color		least two of the layers of the
	imparting agent		substrate
51	.Mask resist contains inorganic	73	.Etching vapor produced by
	material		evaporation, boiling, or
52	MECHANICALLY SHAPING, DEFORMING,		sublimation
	OR ABRADING OF SUBSTRATE	74	.Etching inorganic substrate
53	.Nongaseous phase etching	75	Substrate contains elemental
54	PATTERN OR DESIGN APPLIED BY		metal, alloy thereof, or metal
	TRANSFER		compound
55	HEATING OR BAKING OF SUBSTRATE	76	Etching of substrate
	PRIOR TO ETCHING TO CHANGE THE		containing at least one
	CHEMICAL PROPERTIES OF		compound having at least one
	SUBSTRATE TOWARD THE ETCHANT		oxygen atom and at least one
56	ETCHING TO PRODUCE POROUS OR	77	metal atom
	PERFORATED ARTICLE	1 1	Etching of substrate
57	GAS PHASE AND NONGASEOUS PHASE		<pre>containing elemental aluminum, or an alloy or compound</pre>
	ETCHING ON THE SAME SUBSTRATE		thereof
58	GAS PHASE ETCHING OF SUBSTRATE	78	Etching of substrate
59	.With measuring, testing, or	70	containing elemental copper,
	inspecting		or an alloy or compound
60	By optical means or of an		thereof
	optical property	79	Etching silicon containing
61	By electrical means or of an		substrate
	electrical property	80	Silicon containing substrate
62	.Irradiating, ion implanting,		is glass
	alloying, diffusing, or	81	Etching elemental carbon
	chemically reacting the		containing substrate
	substrate prior to etching to	83	NONGASEOUS PHASE ETCHING OF
	change properties of substrate toward the etchant		SUBSTRATE
63	.Application of energy to the	84	.With measuring, testing, or
0.5	gaseous etchant or to the		inspecting
	substrate being etched	85	By optical means or of an
64	Etchant is devoid of		optical property
0-4	chlorocarbon or fluorocarbon	86	By electrical means or of an
	compound (e.g., C.F.C., etc.)		electrical property
	(2.3.)		

87	.Irradiating, ion implanting, alloying, diffusing, or chemically reacting the substrate prior to ethching to	109Etchant contains fluoride ion
	change properties of substrate toward the etchant	FOREIGN ART COLLECTIONS
88	.Using film of etchant between a stationary surface and a moving surface (e.g., chemical lapping, etc.)	FOR 000 CLASS-RELATED FOREIGN DOCUMENTS
89	<pre>Etchant contains solid particle (e.g., abrasive for polishing, etc.)</pre>	
90	Relative movement between the substrate and a confined pool of etchant	
91	Rotating, repeated dipping, or advancing movement of substrate	
92	Projecting etchant against a moving substrate or controlling the angle or pattern projection of the etchant or controlling the angle or pattern of movement of the substrate	
93	.Recycling, regenerating, or rejunevating etchant	
94	.Etching using radiation (e.g., laser, electron-beam, ion-beam, etc.)	
95	.Substrate is multilayered	
96	.Etching inorganic substrate	
97	Substrate is glass	
98	Frosting glass	
99	Substrate contains silicon or silicon compound	
100	Substrate contains elemental metal, alloy thereof, or metal compound	
101	Etching of a compound containing at least one oxygen atom and at least one metal atom	
102	<pre>Metal is elemental aluminum, an alloy, or compound thereof</pre>	
103	Etchant contains acid	
104	Etchant contains fluoride ion	
105	Metal is elemental copper, an alloy, or compound thereof	
106	Etchant contains acid	
107	Etchant contains fluoride ion	
108	Etchant contains acid	